

# GaAs-IR-Lumineszenzdiode in SMT-Gehäuse

## GaAs Infrared Emitter in SMT Package

SFH 420

SFH 425



SFH 420



SFH 425

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### Wesentliche Merkmale

- GaAs-LED mit sehr hohem Wirkungsgrad
- Gute Linearität ( $I_e = f[I_F]$ ) bei hohen Strömen
- Gleichstrom- (mit Modulation) oder Impulsbetrieb möglich
- Hohe Zuverlässigkeit
- Hohe Impulsbelastbarkeit
- Oberflächenmontage geeignet
- Gegurtet lieferbar
- SFH 420 Gehäusegleich mit SFH 320  
SFH 425 Gehäusegleich mit SFH 325
- SFH 425: Nur für IR-Reflow-Lötung geeignet.

### Features

- Very highly efficient GaAs-LED
- Good Linearity ( $I_e = f[I_F]$ ) at high currents
- DC (with modulation) or pulsed operations are possible
- High reliability
- High pulse handling capability
- Suitable for surface mounting (SMT)
- Available on tape and reel
- SFH 420 same package as SFH 320  
SFH 425 same package as SFH 325
- SFH 425: Suitable only for IR-reflow soldering.

### Anwendungen

- Miniaturlichtschranken für Gleich- und Wechsellichtbetrieb, Lochstreifenleser
- Industrieelektronik
- „Messen/Steuern/Regeln“
- Automobiltechnik
- Sensorik
- Alarm- und Sicherungssysteme
- IR-Freiraumübertragung

### Applications

- Miniature photointerrupters
- Industrial electronics
- For drive and control circuits
- Automotive technology
- Sensor technology
- Alarm and safety equipment
- IR free air transmission

| Typ<br>Type | Bestellnummer<br>Ordering Code | Gehäuse<br>Package  |
|-------------|--------------------------------|---|
| SFH 420     | Q62702-P1690                   | Kathodenkennzeichnung: abgesetzte Ecke<br>cathode marking: bevelled edge<br>TOPLED® |
| SFH 425     | Q62702-P0330                   | SIDELED   |

**Grenzwerte ( $T_A = 25^\circ\text{C}$ )****Maximum Ratings**

| <b>Bezeichnung<br/>Parameter</b>  | <b>Symbol<br/>Symbol</b> | <b>Wert<br/>Value</b> | <b>Einheit<br/>Unit</b> |
|---|--------------------------|-----------------------|-------------------------|
| Betriebs- und Lagertemperatur<br>Operating and storage temperature range  | $T_{op}; T_{stg}$        | - 40 ... + 100        | °C                      |
| Sperrspannung<br>Reverse voltage  | $V_R$                    | 5                     | V                       |
| Durchlaßstrom<br>Forward current  | $I_F$                    | 100                   | mA                      |
| Stoßstrom, $\tau = 10 \mu\text{s}, D = 0$<br>Surge current  | $I_{FSM}$                | 3                     | A                       |
| Verlustleistung<br>Power dissipation  | $P_{tot}$                | 160                   | mW                      |
| Wärmewiderstand Sperrsicht - Umgebung bei<br>Montage auf FR4 Platine, Padgröße je 16 mm <sup>2</sup><br>Thermal resistance junction - ambient mounted<br>on PC-board (FR4), padsize 16 mm <sup>2</sup> each | $R_{thJA}$               | 450                   | K/W                     |
| Wärmewiderstand Sperrsicht - Lötstelle bei<br>Montage auf Metall-Block<br>Thermal resistance junction - soldering point,<br>mounted on metal block  | $R_{thJS}$               | 200                   | K/W                     |

**Kennwerte ( $T_A = 25^\circ\text{C}$ )****Characteristics**

| <b>Bezeichnung<br/>Parameter</b>   | <b>Symbol<br/>Symbol</b>     | <b>Wert<br/>Value</b> | <b>Einheit<br/>Unit</b> |
|--|------------------------------|-----------------------|-------------------------|
| Wellenlänge der Strahlung<br>Wavelength at peak emission<br>$I_F = 100 \text{ mA}, t_p = 20 \text{ ms}$        | $\lambda_{peak}$             | 950                   | nm                      |
| Spektrale Bandbreite bei 50% von $I_{max}$<br>Spectral bandwidth at 50% of $I_{max}$<br>$I_F = 100 \text{ mA}$ | $\Delta\lambda$              | 55                    | nm                      |
| Abstrahlwinkel<br>Half angle   | $\phi$                       | ± 60                  | Grad<br>deg.            |
| Aktive Chipfläche<br>Active chip area  | $A$                          | 0.09                  | mm <sup>2</sup>         |
| Abmessungen der aktiven Chipfläche<br>Dimensions of the active chip area                                       | $L \times B$<br>$L \times W$ | 0.3 × 0.3             | mm                      |

Kennwerte ( $T_A = 25^\circ\text{C}$ )

## Characteristics (cont'd)

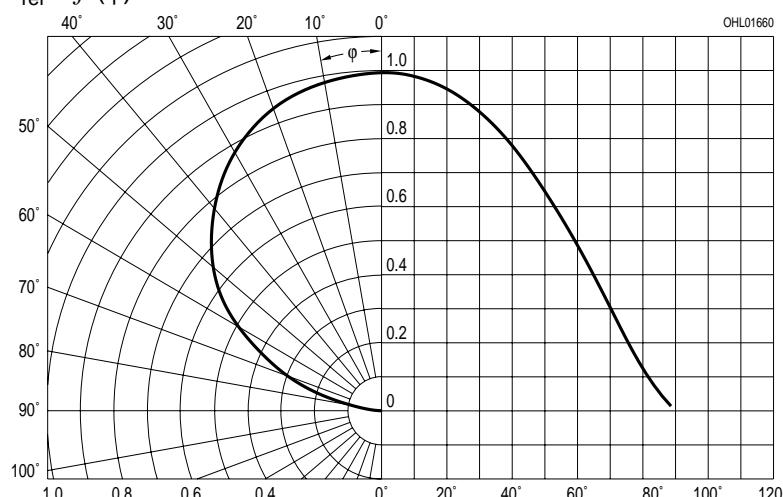
| Bezeichnung<br>Parameter  | Symbol<br>Symbol | Wert<br>Value                            | Einheit<br>Unit |
|---|------------------|--|-----------------|
| Schaltzeiten, $I_e$ von 10% auf 90% und von 90% auf 10%, bei $I_F = 100 \text{ mA}$ , $R_L = 50 \Omega$<br>Switching times, $I_e$ from 10% to 90% and from 90% to 10%, $I_F = 100 \text{ mA}$ , $R_L = 50 \Omega$ | $t_r, t_f$       | 0.5                                      | $\mu\text{s}$   |
| Kapazität,<br>Capacitance<br>$V_R = 0 \text{ V}, f = 1 \text{ MHz}$   | $C_o$            | 25                                       | pF              |
| Durchlaßspannung,<br>Forward voltage<br>$I_F = 100 \text{ mA}, t_p = 20 \text{ ms}$<br>$I_F = 1 \text{ A}, t_p = 100 \mu\text{s}$   | $V_F$<br>$V_F$   | 1.3 ( $\leq 1.5$ )<br>1.9 ( $\leq 2.5$ ) | V<br>V          |
| Sperrstrom,<br>Reverse current<br>$V_R = 5 \text{ V}$   | $I_R$            | 0.01 ( $\leq 1$ )                        | $\mu\text{A}$   |
| Gesamtstrahlungsfluß,<br>Total radiant flux<br>$I_F = 100 \text{ mA}, t_p = 20 \text{ ms}$  | $\Phi_e$         | 14                                       | mW              |
| Temperaturkoeffizient von $I_e$ bzw. $\Phi_e$ ,<br>$I_F = 100 \text{ mA}$<br>Temperature coefficient of $I_e$ or $\Phi_e$ ,<br>$I_F = 100 \text{ mA}$   | $TC_I$           | - 0.55                                   | %/K             |
| Temperaturkoeffizient von $V_F$ , $I_F = 100 \text{ mA}$<br>Temperature coefficient of $V_F$ , $I_F = 100 \text{ mA}$   | $TC_V$           | - 1.5                                    | mV/K            |
| Temperaturkoeffizient von $\lambda$ , $I_F = 100 \text{ mA}$<br>Temperature coefficient of $\lambda$ , $I_F = 100 \text{ mA}$   | $TC_\lambda$     | + 0.3                                    | nm/K            |

**Strahlstärke  $I_e$  in Achsrichtung**gemessen bei einem Raumwinkel  $\Omega = 0.01 \text{ sr}$ **Radiant Intensity  $I_e$  in Axial Direction**at a solid angle of  $\Omega = 0.01 \text{ sr}$ 

| Bezeichnung<br>Parameter   | Symbol               | Werte<br>Values | Einheit<br>Unit |
|--|----------------------|-----------------|-----------------|
| Strahlstärke<br>Radiant intensity<br>$I_F = 100 \text{ mA}, t_p = 20 \text{ ms}$ | $I_e$                | > 2.5           | mW/sr           |
| Strahlstärke<br>Radiant intensity<br>$I_F = 1 \text{ A}, t_p = 100 \mu\text{s}$  | $I_{e \text{ typ.}}$ | 38              | mW/sr           |

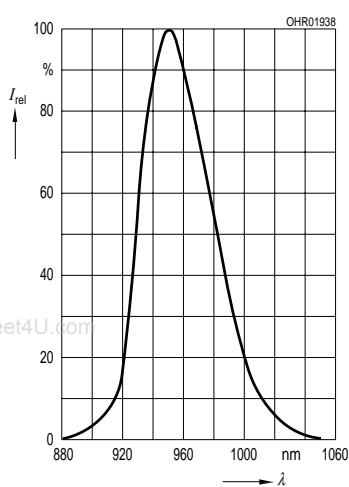
**Radiation Characteristics**

$$S_{\text{rel}} = f(\phi)$$



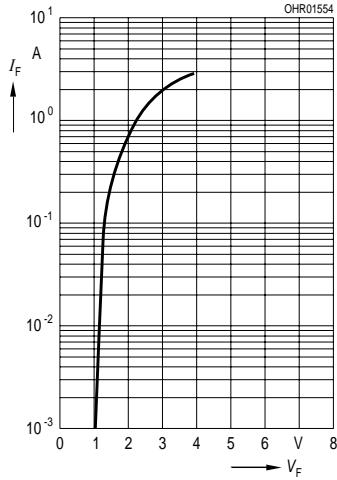
**Relative Spectral Emission**

$$I_{\text{rel}} = f(\lambda)$$



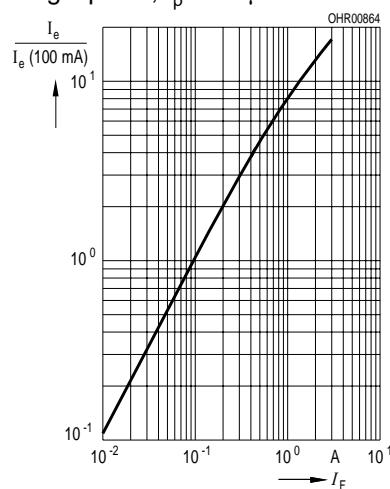
**Forward Current**

$$I_F = f(V_F), \text{ single pulse, } t_p = 20 \mu\text{s}$$



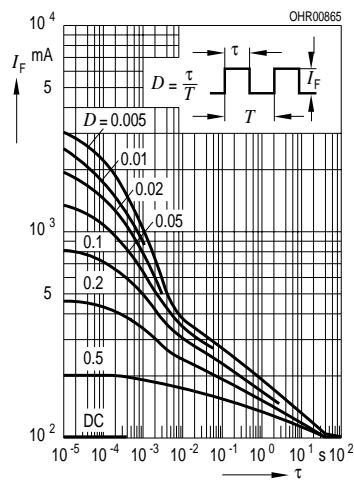
$$\frac{I_e}{I_e \text{ 100 mA}} = f(I_F)$$

Single pulse,  $t_p = 20 \mu\text{s}$



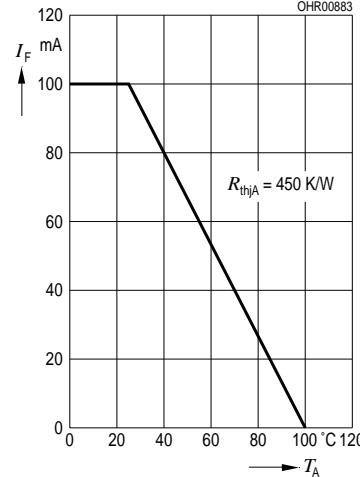
**Permissible Pulse Handling Capability**

$$I_F = f(t_p), \text{ duty cycle } D = \text{parameter}, T_A = 20^\circ\text{C}$$

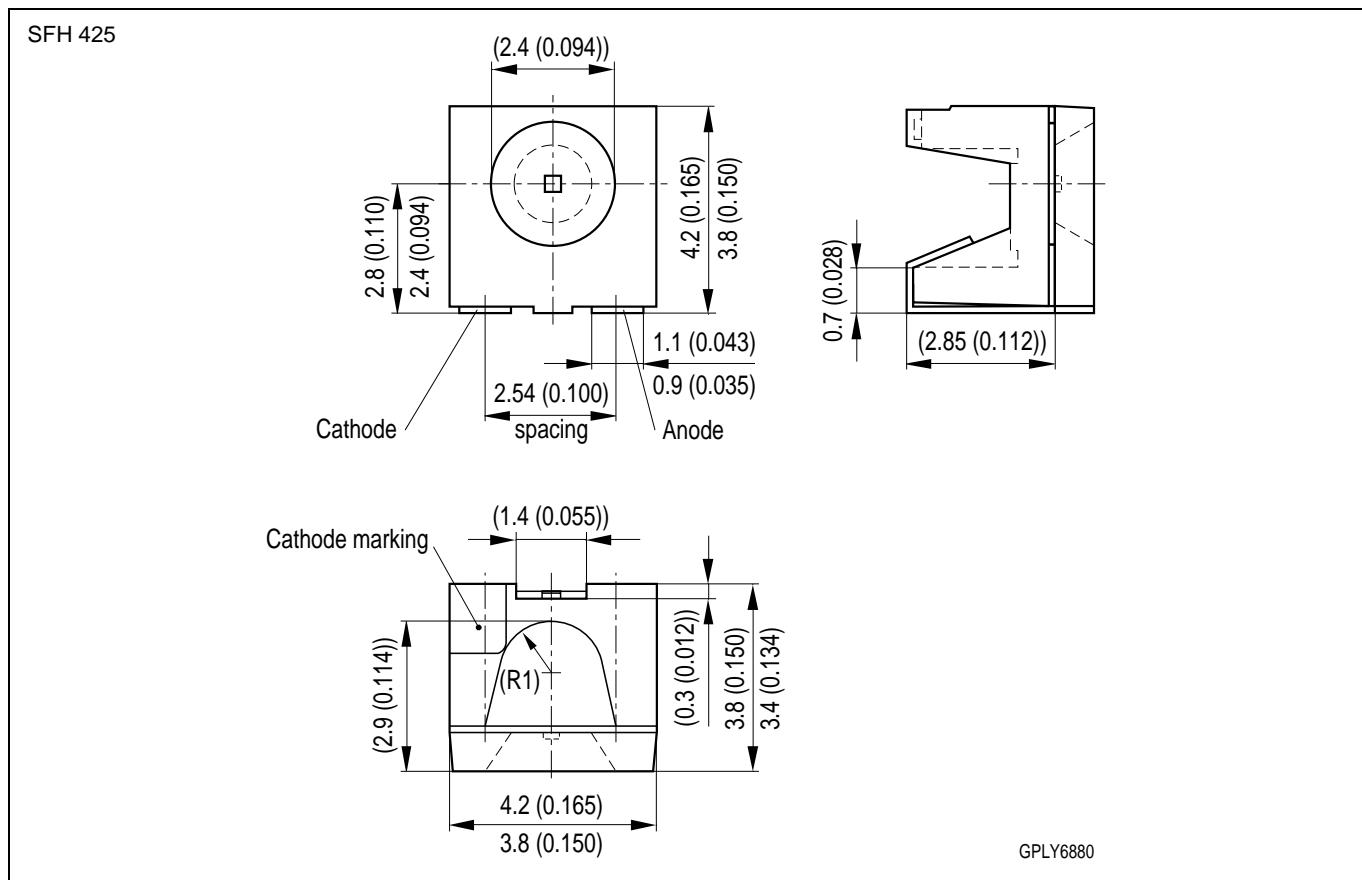
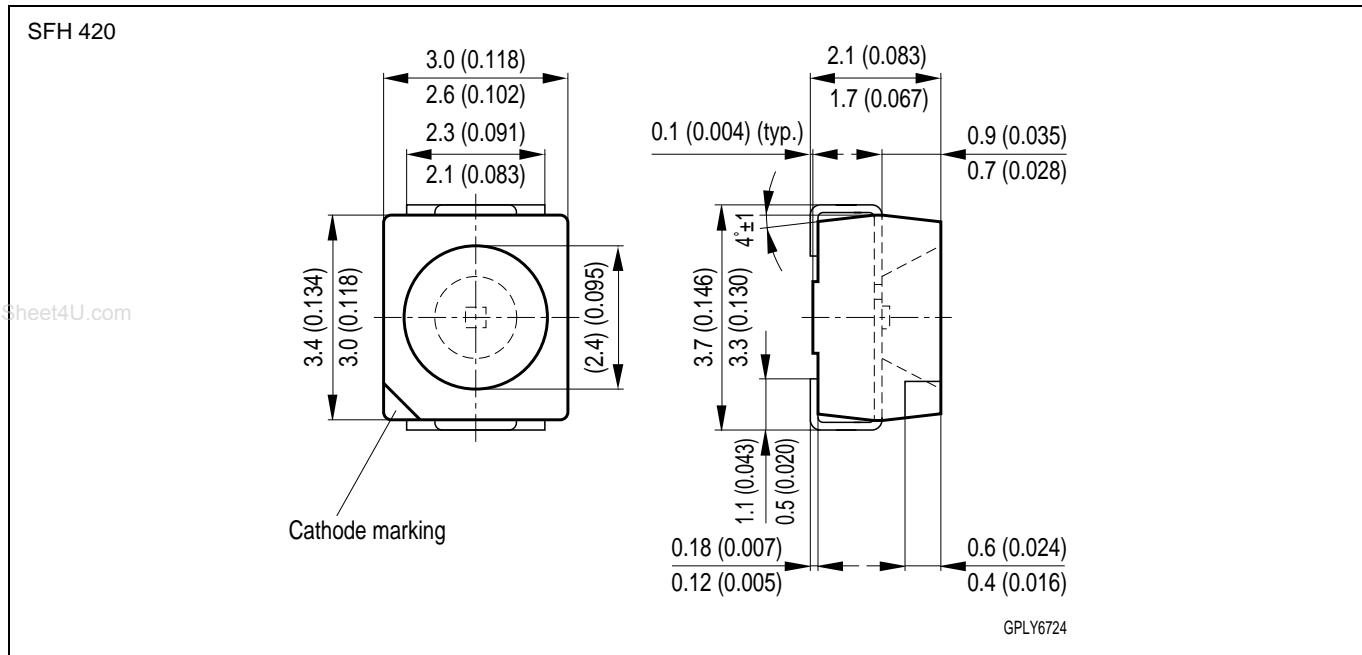


**Max. Permissible Forward Current**

$$I_F = f(T_A)$$



## Maßzeichnung Package Outlines



Maße werden wie folgt angegeben: mm (inch) / Dimensions are specified as follows: mm (inch).

**Löthinweise****Soldering Conditions**

| Bauform<br>Types | Tauch-, Schwall- und Schleplötung<br>Dip, Wave and Drag Soldering |  |   | Reflowlötung<br>Reflow Soldering                     |   |
|------------------|---|--|---|--|---|
|                  | Lötbad-temperatur<br>Temperature of the Soldering Bath            | Maximal zulässige Lötzeit<br>Max. Perm. Soldering Time | Abstand Lötstelle – Gehäuse<br>Distance between Solder Joint and Case | Lötzonen-temperatur<br>Temperature of Soldering Zone | Maximale Durchlaufzeit<br>Max. Transit Time |
| TOPLED           | 260 °C  | 10 s   | –   | 245 °C   | 10 s  |
| SIDELED          | –   | –  | –   | ≥ 225 °C   | 10 s  |

Zusätzliche Informationen über allgemeine Lötbedingungen erhalten Sie auf Anfrage.

For additional information on general soldering conditions please contact us.

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**Attention please!**

The information describes the type of component and shall not be considered as assured characteristics.

Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances. For information on the types in question please contact our Sales Organization.

**Packing**

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

**Components used in life-support devices or systems must be expressly authorized for such purpose!** Critical components<sup>1</sup>, may only be used in life-support devices or systems<sup>2</sup> with the express written approval of OSRAM OS.

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